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Attorney Docket No. 108075-00072

Date: 108075-00072

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Name of conveying party(ies)	Name and address of receiving party(ies):	
Masayuki TAKESHIGE, Sumitaka HIBINO, Kenji YAMADA	Name: FUJITSU LIMITED	
Additional name(s) of conveying party(ies) attached?	Address: 1-1, Kamikodanaka 4-chome, Nakahara-ku, Kawasaki-shi, Kanagawa 211-8588 Japan	
☐ Yes	Additional name(s) & address(es) attached?	
mes	☐ Yes ☑ No	
3. Nature of conveyance:		
□ Assignment		
Execution Date: <u>December 12, 2001</u>		
4. Application number(s) or patent number(s): If this document is being filed together with a new application, the case of t	B. Patent No.(s)	
Name and address of party to whom correspondence concerning document should be mailed:	Total number of applications and patents involved: One	
Name: Arent Fox Kintner Plotkin & Kahn PLLC	7. Total fee (37 CFR 3.41) \$ 40.00	
Street Address: 1050 Connecticut Avenue, N.W., Suite 400	☑ Included in attached check.	
Washington, D.C. 20036-5339	Any additional fees are authorized to be charged to deposit account	
0/2001 HDEMESS1 00000018 10026560	8. Deposit account number: 01-2300 (Attach duplicate copy of this page if paying by deposit account)	
	E THIS SPACE	
9. Statement and signature. To the best of my knowledge and belief, the foregoing information copy of the original document. Charles M. Marmelstein Name of Person Signing Reg. No. 25,895	December 27, 2001 Signature District and any attached copy is a true December 27, 2001	
Total number	er of pages including cover sheet, attachments, and document: 2	

ARENT FOX KINTNER PLOTKIN & KAHN, PLLC Nikardo, Marmelstein, Murray & Oram Intellectual Property Group

Docket No:

U.S. ASSIGNMENT

IN CONSIDERATION of the sum of One Dollar (\$1.00), and of other good and valuable consideration paid to the undersigned inventors (hereinafter ASSIGNOR) by:

FUJITSU LIMITED

1-1, Kamikodanaka 4-chome, Nakahara-ku, Kawasaki-shi, Kanagawa 211-8588 Japan

(hereinafter ASSIGNEE), the receipt of which is hereby acknowledged, the undersigned ASSIGNOR hereby sells, assigns and transfers to ASSIGNEE the entire and exclusive right, title and interest to the invention entitled:

TEST METHOD AND TEST SYSTEM FOR SEMICONDUCTOR DEVICE

for which application for L	etters Patent of the United States was file	ed on,
and all Letters Patent of	(Arent Forest the series code, serial number and/or the United States to be obtained there wal, substitute, reissue or reexamination granted.	efor on said application or any
continuing, divisional, reis	grees to execute all papers necessary in consider or reexamination applications there with such applications as the ASSIGNEE results.	of and also to execute separate
litigation, or other legal properties continuation, division, reinthereon and to cooperate	grees to execute all papers necessary in coroceeding which may be declared conssue or reexamination thereof or Letters with the ASSIGNEE in every way possible the such interference, litigation, or other	ncerning this application or any s Patent or reissue patent issued sible in obtaining and producing
IN WITNESS WHEREOF	, the undersigned inventors have affixed	their signatures.
Masayuki TAKESHIGE	Masoyuki Takeshige	December 12, 2001 (DATE)
Sumitaka HIBINO	Nasayuki Takeshige (SIGNATURE) Similaka Bibino (SIGNATURE)	December 12, 2001 (DATE)
Kenji YAMADA	Kenji Yamada	December 12, 2001
	(SIGNATURE)	(DATE)

(SIGNATURE)

NO LEGALIZATION REQUIRED

PATENT RECORDED: 12/27/2001 REEL: 012415 FRAME: 0253

(DATE)